BS78 (with/without reference point)

High-speed and high-resolution, while maintaining stable, ultraprecision measuring. Ideal for precision stages, semiconductor inspection/manufacturing systems, and ultraprecision processing machines.

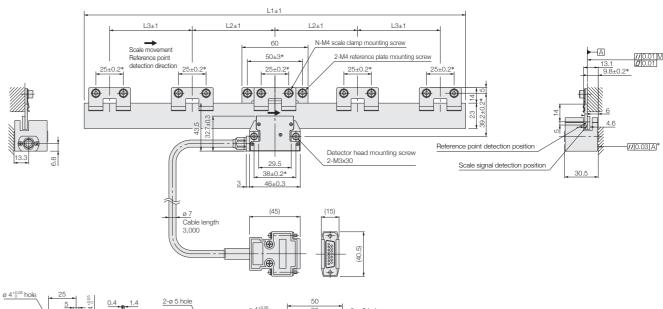


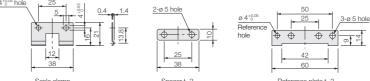
- High-resolution scale with signal pitch of approx. 138 nm, outperforming light wave interferometer systems
- High stability, unaffected by humidity, air pressure and air disturbances
- Reference point accuracy: ±0.1 μm
- Scale accuracy: ±0.04 µm (measuring length: 40 mm)
- Non-contact design eliminates return error.
- Special non-magnetic and vacuum-compatible models available
- Using low expansion glass: -0.7 x 10⁻⁶/°C (measuring length: 10 to 420 mm)



External Dimensions

● BS78-xxxR(RS) (Measuring length: 40/120/170/220/370/420 mm)





Note 1: The items marked by an asterisk indicate the machining dimensions on the mounting surface.

Note 2: The surface properties of the scale mounting surface is Rmax = 6.35.

Note 3: The surface properties of the detector head mounting surface is Rmax = 12.5S.

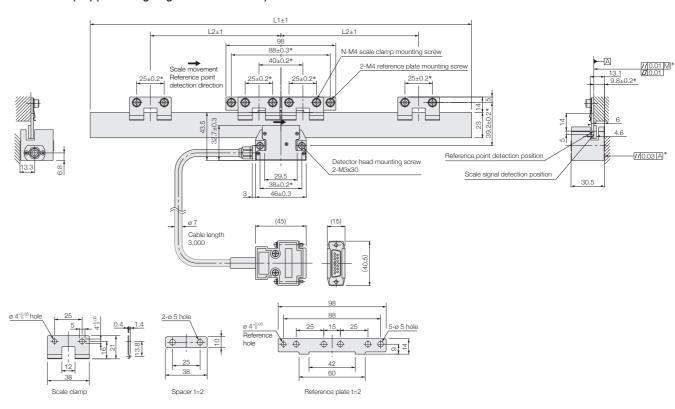
Note 4: "M" refers to the machine guide.

Note 5: Mount and adjust the paired reference plates so that their reference surfaces have a parallelism of 0.01 or less with respect to the machine quicle

Note 6 : Reference point detection direction : Standard (Scale movement direction → with the head stationary)

Model	L1	L2	L3	N
BS78-40R (RS)	66	_	_	2
BS78-120R (RS)	146	50	_	6
BS78-170R (RS)	196	75	_	6
BS78-220R (RS)	246	100	_	6
BS78-370R (RS)	396	75	75	10
BS78-420R (RS)	446	100	100	10
	•			•

● BS78-xxxR(RS) (Measuring length: 70/270/320 mm)



Note 1: The items marked by an asterisk indicate the machining dimensions on the mounting surface.

Note 2: The surface properties of the scale mounting surface is Rmax = 6.3S.

Note 3: The surface properties of the detector head mounting surface is Rmax = 12.5S.

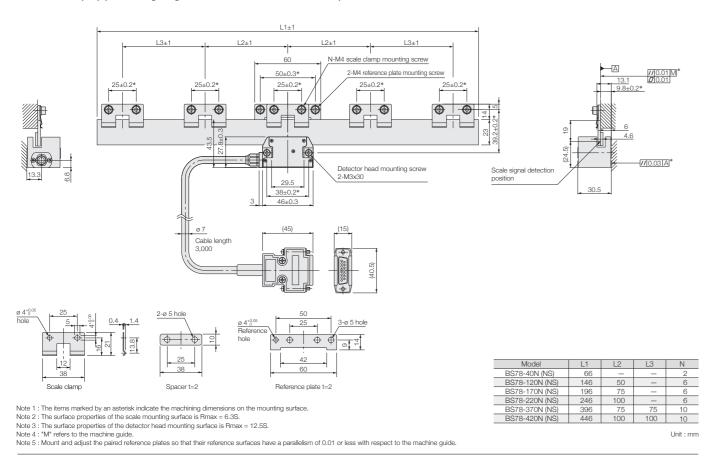
Note 4: "M" refers to the machine guide.

Note 5: Mount and adjust the paired reference plates so that their reference surfaces have a parallelism of 0.01 or less with respect to the machine guide.

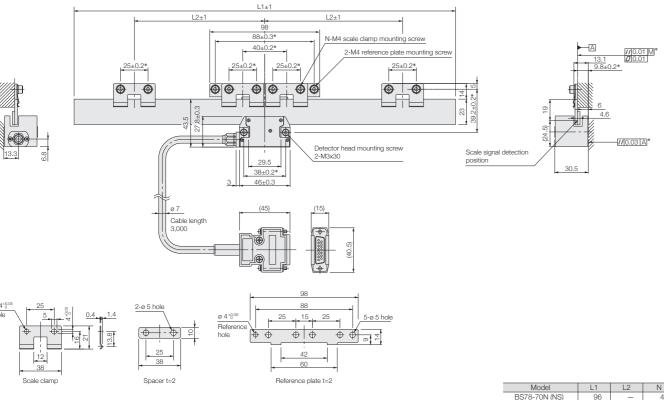
Note 6: Reference point detection direction: Standard (Scale movement direction -- with the head stationary)

Model	L1	L2	N
BS78-70R (RS)	96	_	4
BS78-270R (RS)	296	120	8
BS78-320R (RS)	346	120	8
			Unit : mm

● BS78-xxxN(NS) (Measuring length: 40/120/170/220/370/420 mm)



● BS78-xxxN(NS) (Measuring length:70/270/320 mm)



Note 1: The items marked by an asterisk indicate the machining dimensions on the mounting surface.

Note 2: The surface properties of the scale mounting surface is Rmax = 6.3S.

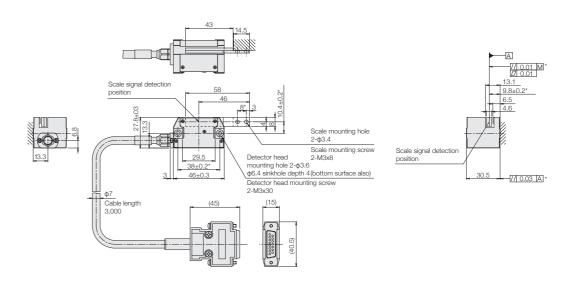
Note 3: The surface properties of the detector head mounting surface is Rmax = 12.5S.

Note 4: "M" refers to the machine guide.

Note 5: Mount and adjust the paired reference plates so that their reference surfaces have a parallelism of 0.01 or less with respect to the machine guide.

External Dimensions

● BS78-10N/NS (Measuring length: 10 mm)



Note 1: The items marked by an asterisk indicate the machining dimensions on the mounting surface.

Note 2: The surface properties of the scale mounting surface is Rmax = 6.3S.

Note 3: The surface properties of the detector head mounting surface is Rmax = 12.5S.

Note 4: "M" refers to the machine guide. Unit : mm

Model	BS78				
Measuring length	10 (only N/NS)/40/70/120/170/220/270/320/370/420 mm				
Overall length	58 mm (L=10mm : open type scale), L + 26 mm (L= 40 mm to 420 mm) L : Measuring length				
Max. travel	L + 2 mm (L=10 mm: open type scale), L +10 mm (L= 40 mm to 420 mm) L: Measuring length				
Scale accuracy (at 20 °C)	NS type, RS type : ±0.03 µm (L=10 mm : NS type) ±0.25 µm (L=270 mm) ±0.04 µm (L=40 mm) ±0.34 µm (L=320 mm) ±0.10 µm (L=70/120 mm) ±0.39 µm (L=370 mm) ±0.18 µm (L=170/220 mm) ±0.44 µm (L=420 mm) L : Measuring length	N type, R type: ±0.06 μm (L=10 mm : N type) ±0.35 μm (L=170/220 mm) ±0.08 μm (L=40 mm) ±0.50 μm (L=270 to 370 mm) ±0.20 μm (L=70/120 mm) ±0.65 μm (L=420 mm) L : Measuring length			
Grating pitch	Арргох. 0.55 µm				
Signal pitch	Арргох. 0.138 µm (Арргох. 138 nm)				
Reference point accuracy	0.1 μm (Only R/RS type)				
Reference point position	At the center, and every 50 mm from the center to the left and to the right (BS78 models with measuring lengths of 320, 370, 420 mm : 20 mm offset from the center at 50 mm interval				
Reference point detection direction	Single direction				
Return error	This is virtually eliminated.				
Repeatability	This is virtually eliminated.				
Thermal expansion coefficient	-0.7 x 10 ⁻⁶ / °C				
Light source	Semiconductor laser : Wavelength 790 nm, Output 6 mW				
Radiation power	DHHS class 1				
Detection principle	Diffraction grating scanning system				
Operating temperature	+10 to +30 °C (No condensation)				
Storage temperature	-10 to +50 °C (Humidity 60 % or less)				
Max. response speed	400 mm/s (When connected with BD700)				

Magnescale reserves the right to change product specifications without prior notice.

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